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Kind regards,

Team Nexperia



# BSS84AK

50 V, 180 mA P-channel Trench MOSFET

Rev. 1 — 23 May 2011

Product data sheet

## 1. Product profile

### 1.1 General description

P-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

### 1.2 Features and benefits

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology
- ESD protection up to 1 kV
- AEC-Q101 qualified

### 1.3 Applications

- Relay driver
- High-speed line driver
- High-side loadswitch
- Switching circuits

### 1.4 Quick reference data

Table 1. Quick reference data

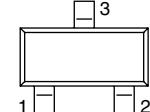
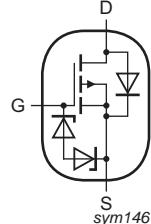
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage	$T_j = 25^\circ\text{C}$	-	-	-50	V
$V_{GS}$	gate-source voltage		-20	-	20	V
$I_D$	drain current	$V_{GS} = -10\text{ V}; T_{amb} = 25^\circ\text{C}$	[1]	-	-180	mA
<b>Static characteristics</b>						
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = -10\text{ V}; I_D = -100\text{ mA}; T_j = 25^\circ\text{C}$	-	4.5	7.5	$\Omega$

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.



## 2. Pinning information

**Table 2.** Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source		
3	D	drain	 <b>SOT23 (TO-236AB)</b>	 <b>sym146</b>

## 3. Ordering information

**Table 3.** Ordering information

Type number	Package			Version
	Name	Description		
BSS84AK	TO-236AB	plastic surface-mounted package; 3 leads		SOT23

## 4. Marking

**Table 4.** Marking codes

Type number	Marking code <sup>[1]</sup>
BSS84AK	%VS

[1] % = placeholder for manufacturing site code

## 5. Limiting values

**Table 5. Limiting values**

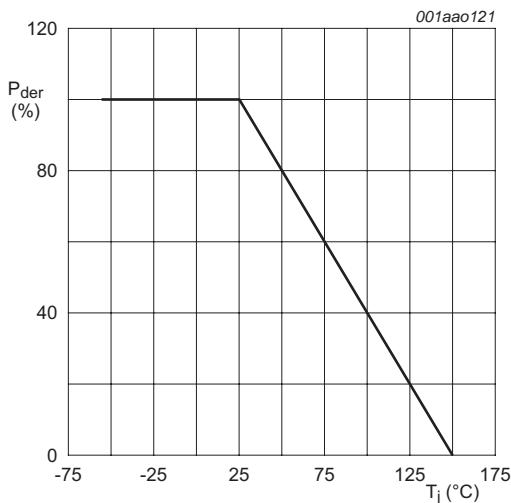
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C	-	-50	V
V <sub>GS</sub>	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = -10 V; T <sub>amb</sub> = 25 °C	[1]	-	-180 mA
		V <sub>GS</sub> = -10 V; T <sub>amb</sub> = 100 °C	[1]	-	-120 mA
I <sub>DM</sub>	peak drain current	T <sub>amb</sub> = 25 °C; single pulse; t <sub>p</sub> ≤ 10 µs	-	-0.7	A
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	[2]	-	350 mW
		T <sub>sp</sub> = 25 °C	[1]	-	420 mW
T <sub>j</sub>	junction temperature		-55	150	°C
T <sub>amb</sub>	ambient temperature		-55	150	°C
T <sub>stg</sub>	storage temperature		-65	150	°C
<b>Source-drain diode</b>					
I <sub>S</sub>	source current	T <sub>amb</sub> = 25 °C	[1]	-	-180 mA
<b>ESD maximum rating</b>					
V <sub>ESD</sub>	electrostatic discharge voltage	HBM	[3]	-	1000 V

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.

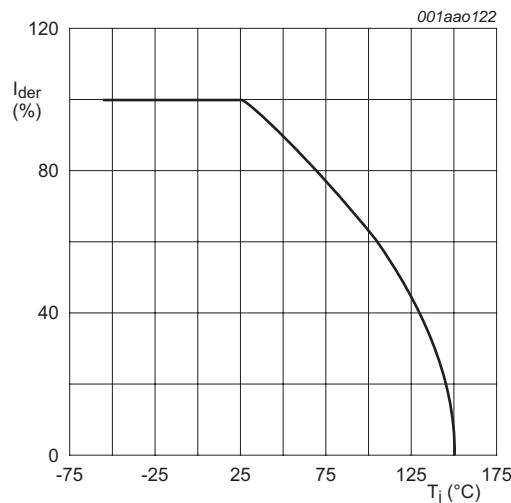
[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[3] Measured between all pins.



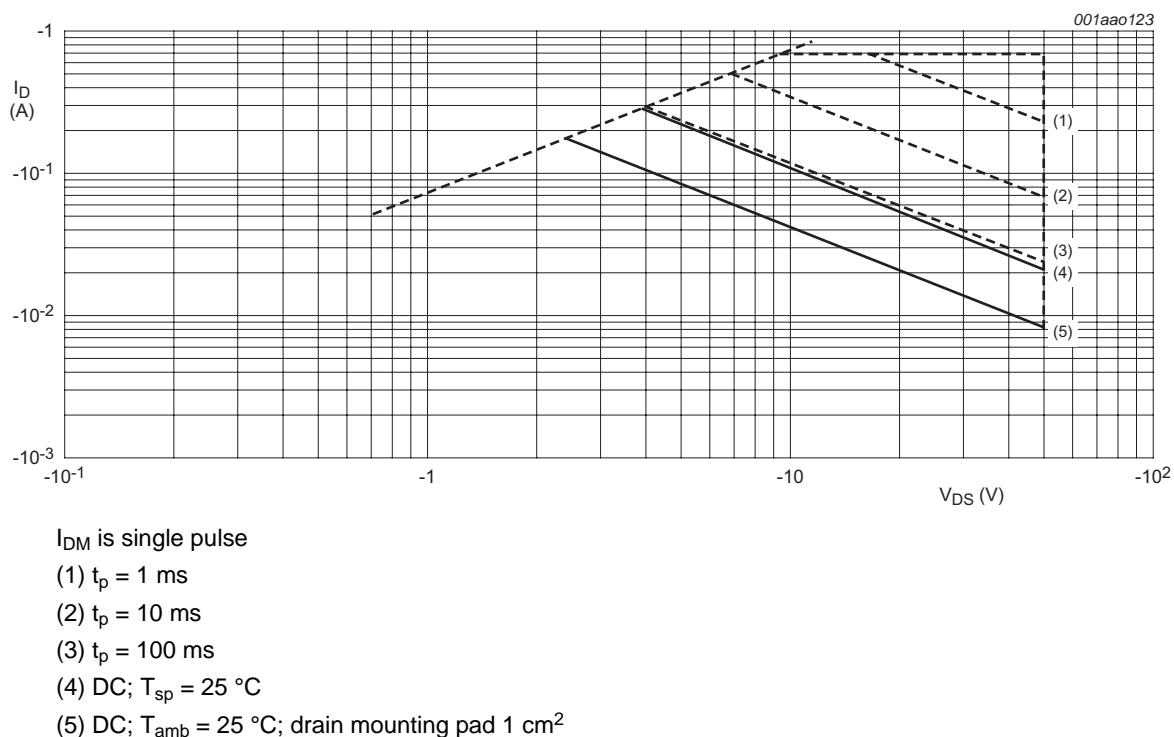
$$P_{der} = \frac{P_{tot}}{P_{tot}(25^{\circ}\text{C})} \times 100 \%$$

**Fig 1. Normalized total power dissipation as a function of junction temperature**



$$I_{der} = \frac{I_D}{I_D(25^{\circ}\text{C})} \times 100 \%$$

**Fig 2. Normalized continuous drain current as a function of junction temperature**



**Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage**

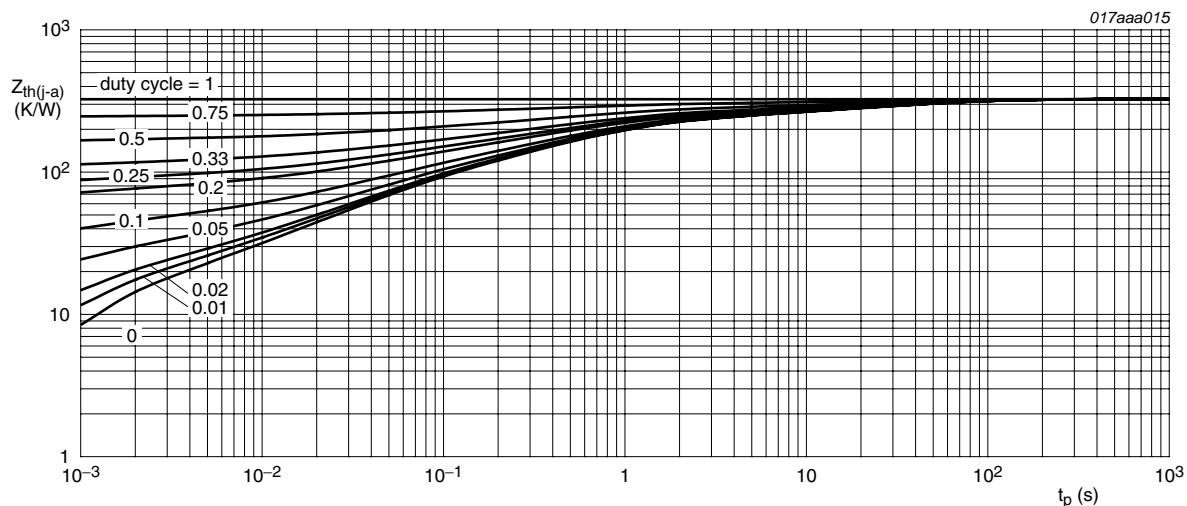
## 6. Thermal characteristics

**Table 6. Thermal characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	310	K/W
			[2]	-	260	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	115	K/W

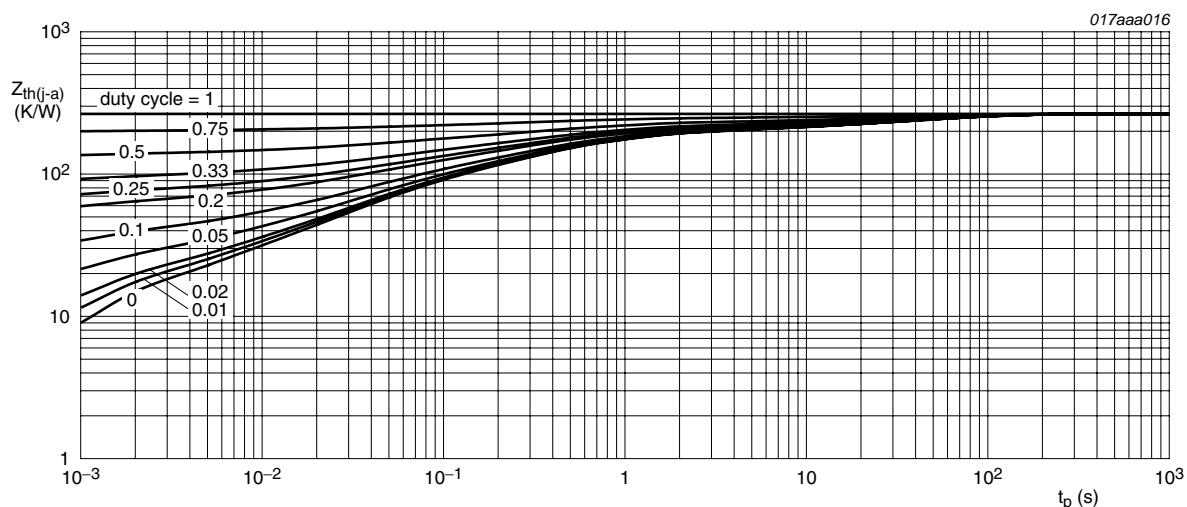
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.



FR4 PCB, standard footprint

**Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



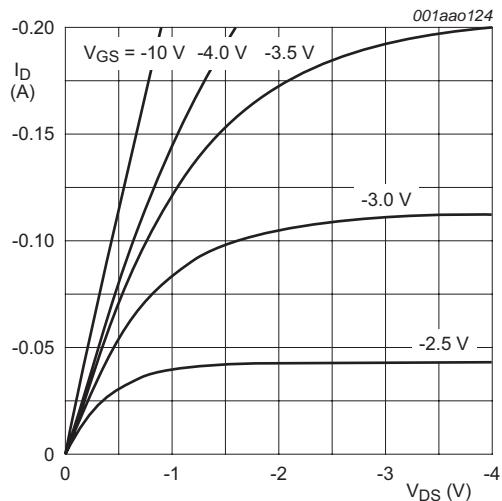
FR4 PCB, mounting pad for drain 1 cm<sup>2</sup>

**Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**

## 7. Characteristics

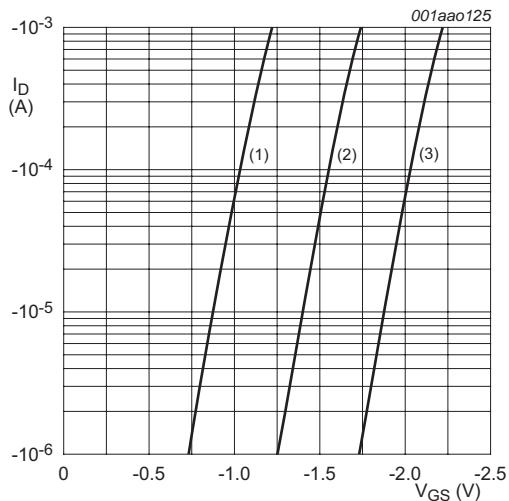
**Table 7. Characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = -10 \mu A; V_{GS} = 0 V; T_j = 25^\circ C$	-50	-	-	V
$V_{GSth}$	gate-source threshold voltage	$I_D = -250 \mu A; V_{DS} = V_{GS}; T_j = 25^\circ C$	-1.1	-1.6	-2.1	V
$I_{DSS}$	drain leakage current	$V_{DS} = -50 V; V_{GS} = 0 V; T_j = 25^\circ C$	-	-	-1	$\mu A$
		$V_{DS} = -50 V; V_{GS} = 0 V; T_j = 150^\circ C$	-	-	-2	$\mu A$
$I_{GSS}$	gate leakage current	$V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25^\circ C$	-	-	-10	$\mu A$
		$V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25^\circ C$	-	-	-10	$\mu A$
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = -10 V; I_D = -100 mA; T_j = 25^\circ C$	-	4.5	7.5	$\Omega$
		$V_{GS} = -10 V; I_D = -100 mA; T_j = 150^\circ C$	-	8	13.5	$\Omega$
		$V_{GS} = -5 V; I_D = -100 mA; T_j = 25^\circ C$	-	5.7	8.5	$\Omega$
$g_{fs}$	forward transconductance	$V_{DS} = -10 V; I_D = -100 mA; T_j = 25^\circ C$	-	150	-	$mS$
<b>Dynamic characteristics</b>						
$Q_{G(tot)}$	total gate charge	$V_{DS} = -25 V; I_D = -200 mA; V_{GS} = -5 V;$ $T_j = 25^\circ C$	-	0.26	0.35	nC
$Q_{GS}$	gate-source charge		-	0.12	-	nC
$Q_{GD}$	gate-drain charge		-	0.09	-	nC
$C_{iss}$	input capacitance	$V_{DS} = -25 V; f = 1 MHz; V_{GS} = 0 V;$ $T_j = 25^\circ C$	-	24	36	pF
$C_{oss}$	output capacitance		-	4.5	-	pF
$C_{rss}$	reverse transfer capacitance		-	1.3	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = -30 V; R_L = 250 \Omega; V_{GS} = -10 V;$ $R_{G(ext)} = 6 \Omega; T_j = 25^\circ C$	-	13	26	ns
$t_r$	rise time		-	11	-	ns
$t_{d(off)}$	turn-off delay time		-	48	96	ns
$t_f$	fall time		-	25	-	ns
<b>Source-drain diode</b>						
$V_{SD}$	source-drain voltage	$I_S = -115 mA; V_{GS} = 0 V; T_j = 25^\circ C$	-0.48	-0.85	-1.2	V



$T_j = 25^\circ\text{C}$

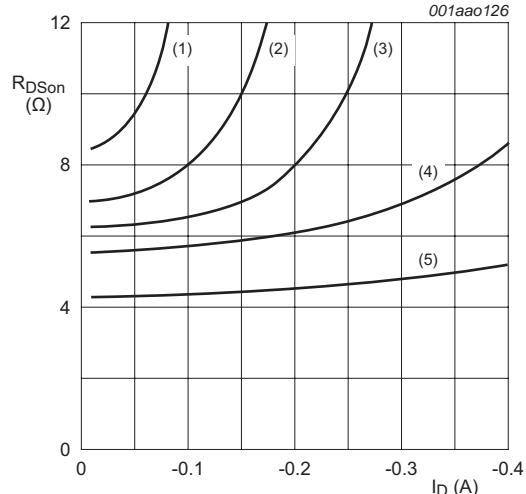
**Fig 6. Output characteristics; drain current as a function of drain-source voltage; typical values**



$T_j = 25^\circ\text{C}; V_{DS} = -5\text{ V}$

- (1) minimum values
- (2) typical values
- (3) maximum values

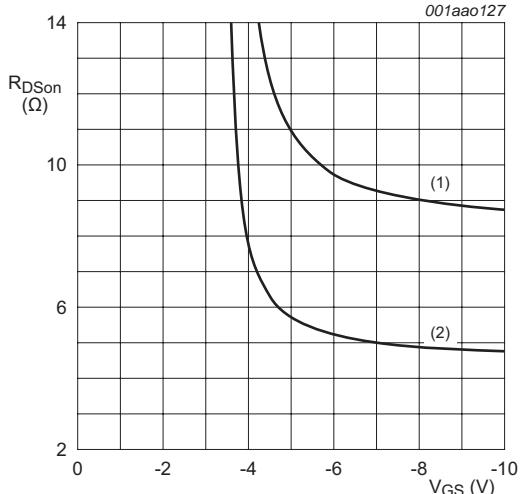
**Fig 7. Sub-threshold drain current as a function of gate-source voltage**



$T_j = 25^\circ\text{C}$

- (1)  $V_{GS} = -3.0\text{ V}$
- (2)  $V_{GS} = -3.5\text{ V}$
- (3)  $V_{GS} = -4.0\text{ V}$
- (4)  $V_{GS} = -5.0\text{ V}$
- (5)  $V_{GS} = -10.0\text{ V}$

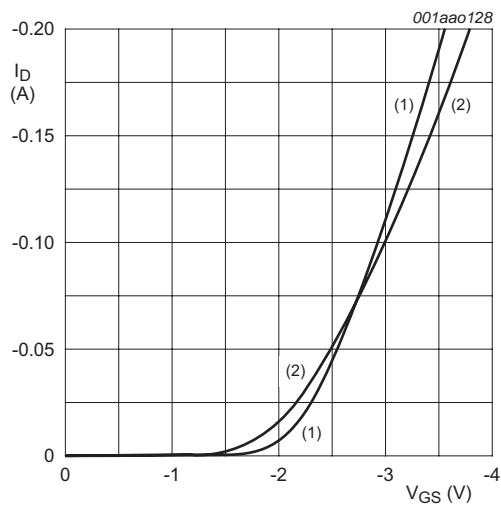
**Fig 8. Drain-source on-state resistance as a function of drain current; typical values**



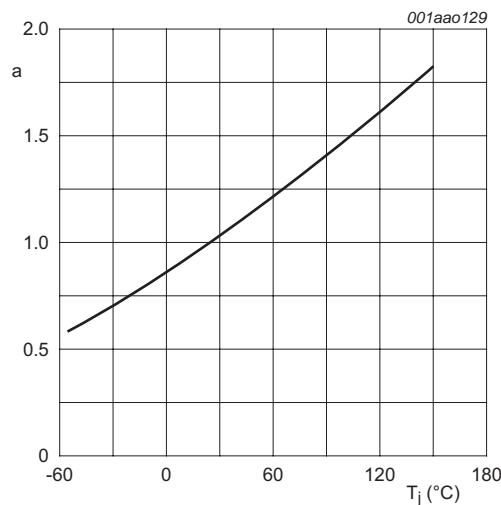
$I_D = -200\text{ mA}$

- (1)  $T_j = 150^\circ\text{C}$
- (2)  $T_j = 25^\circ\text{C}$

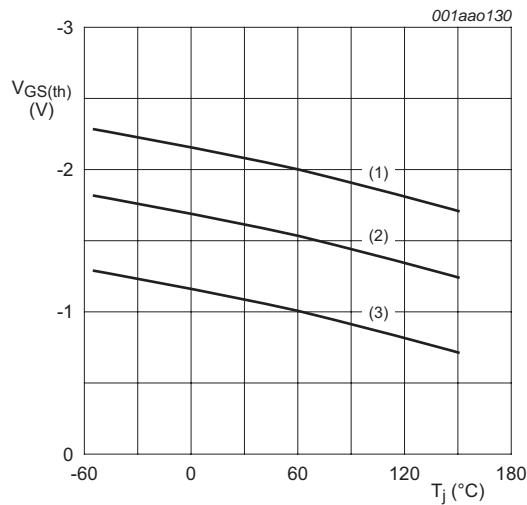
**Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values**



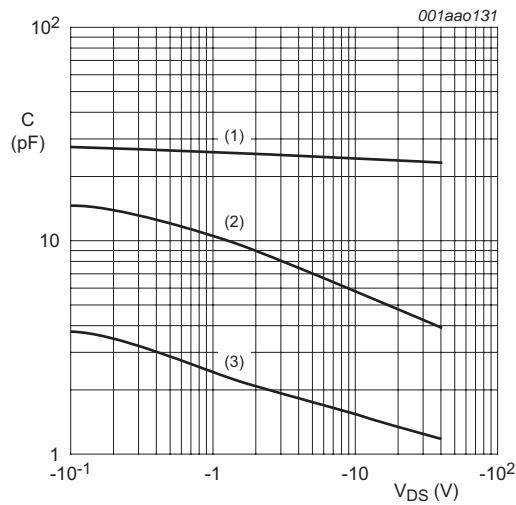
**Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values**



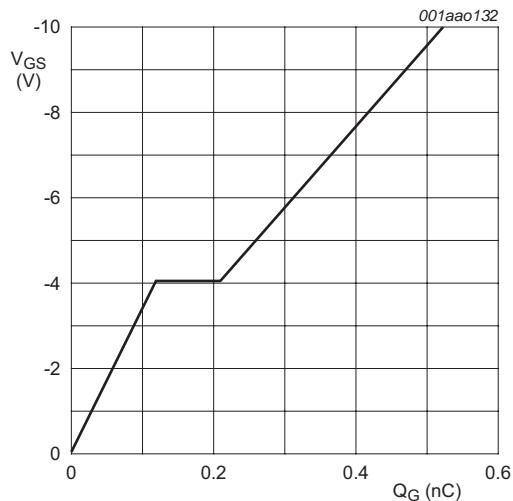
**Fig 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values**



**Fig 12. Gate-source threshold voltage as a function of junction temperature**

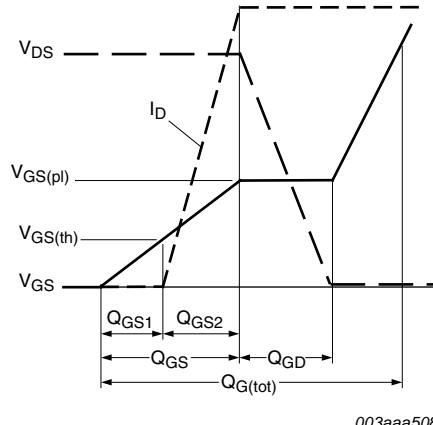


**Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**

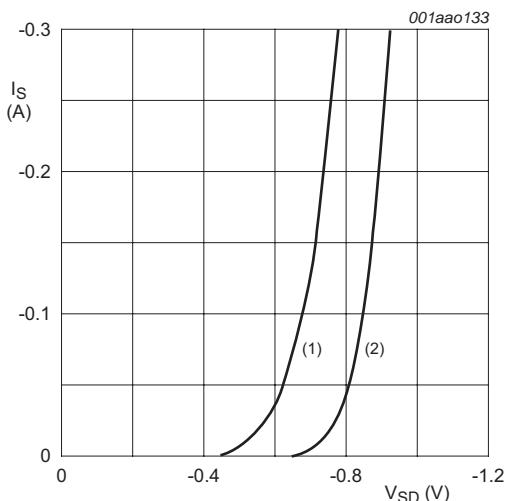


$I_D = -0.2 \text{ A}$ ;  $V_{DS} = -25 \text{ V}$ ;  $T_{amb} = 25 \text{ }^\circ\text{C}$

**Fig 14. Gate-source voltage as a function of gate charge; typical values**



**Fig 15. Gate charge waveform definitions**



$V_{GS} = 0 \text{ V}$

(1)  $T_j = 150 \text{ }^\circ\text{C}$

(2)  $T_j = 25 \text{ }^\circ\text{C}$

**Fig 16. Source current as a function of source-drain voltage; typical values**

## 8. Test information

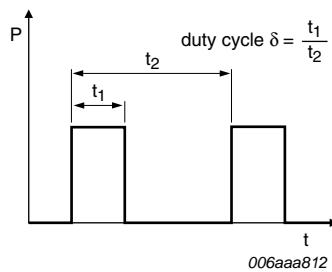


Fig 17. Duty cycle definition

### 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

## 9. Package outline

Plastic surface-mounted package; 3 leads

SOT23

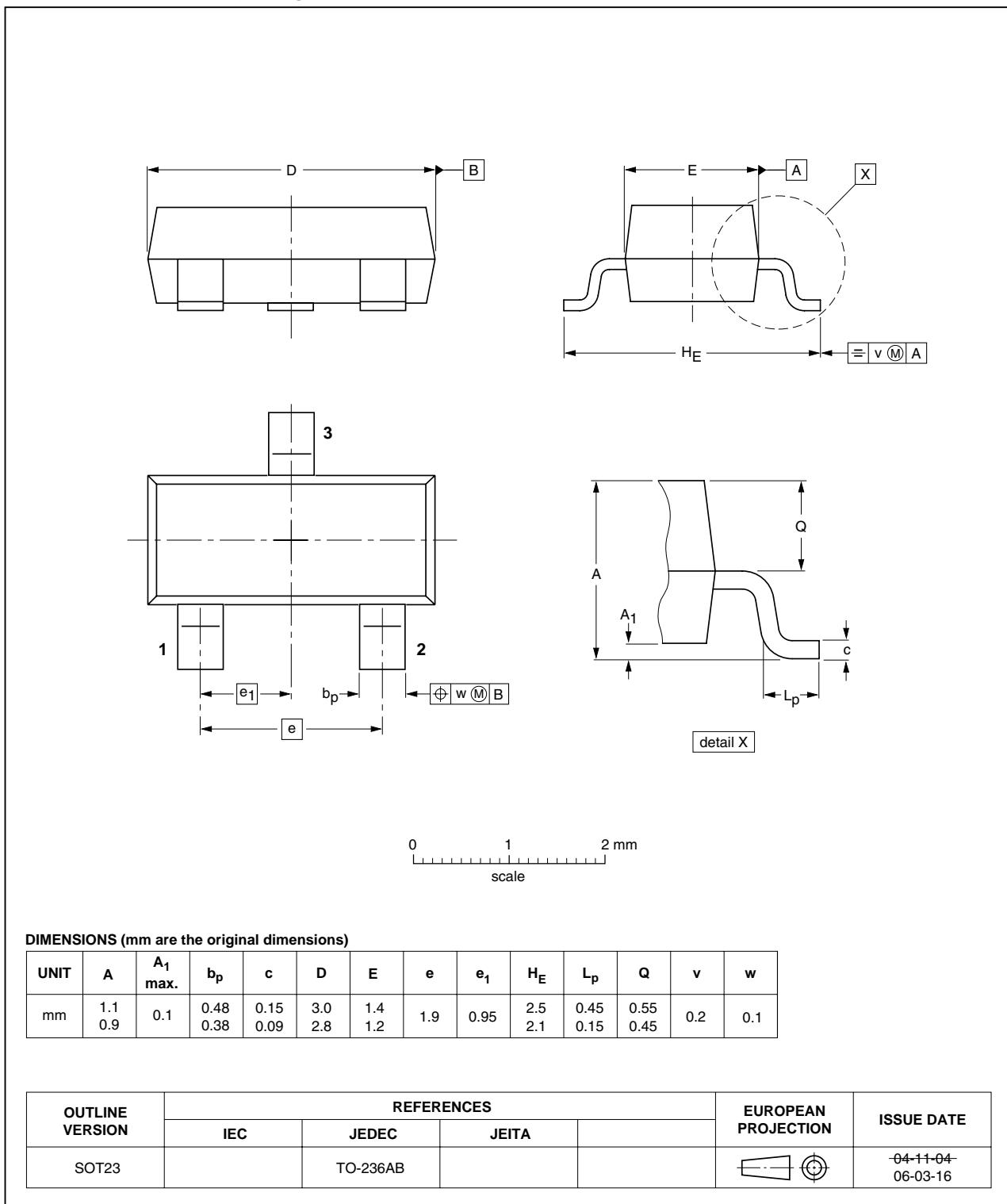
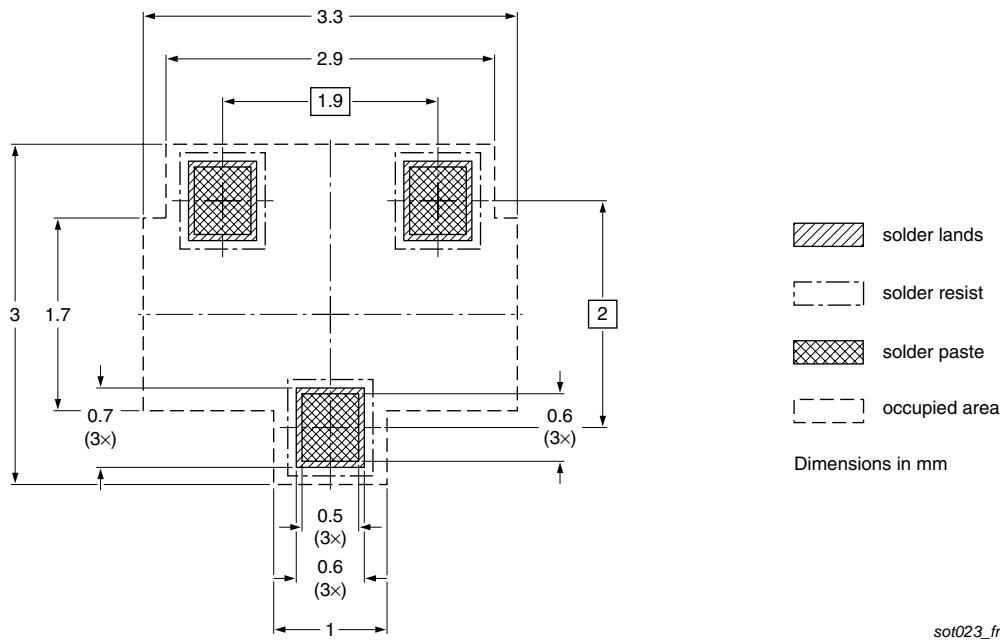
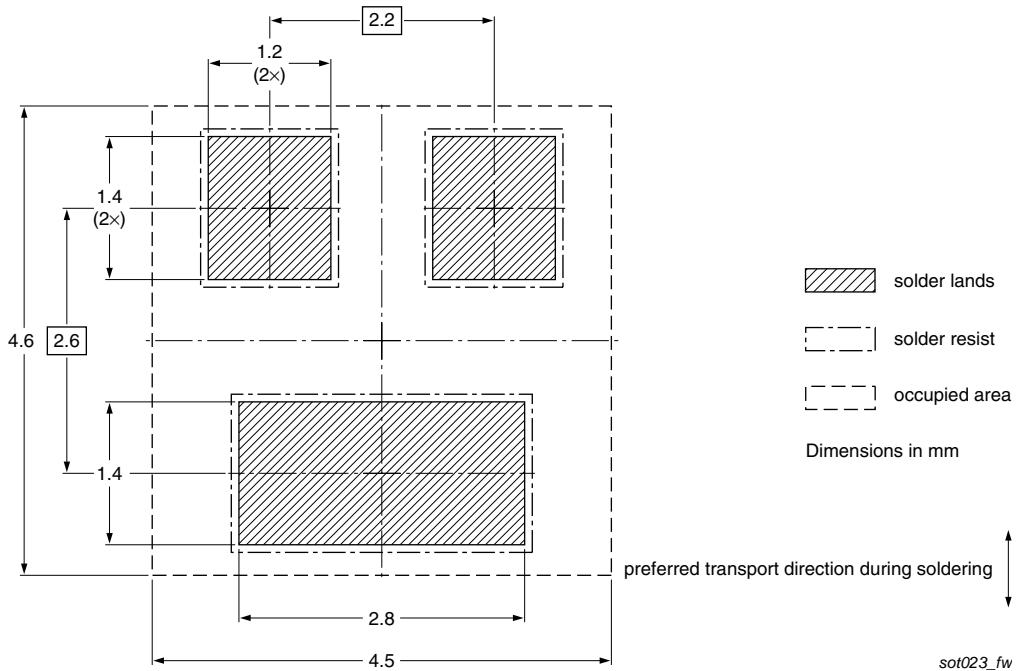


Fig 18. Package outline SOT23 (TO-236AB)

## 10. Soldering



**Fig 19. Reflow soldering footprint for SOT23 (TO-236AB)**



**Fig 20. Wave soldering footprint for SOT23 (TO-236AB)**

## 11. Revision history

**Table 8. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BSS84AK v.1	20110523	Product data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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